# DATA SHEET



# MOS INTEGRATED CIRCUIT $\mu$ PD23C16300

# 16M-BIT MASK-PROGRAMMABLE ROM 2M-WORD BY 8-BIT (BYTE MODE) / 1M-WORD BY 16-BIT (WORD MODE)

# Description

The  $\mu$ PD23C16300 is a 16,777,216 bits mask-programmable ROM. The word organization is selectable (BYTE mode : 2,097,152 words by 8 bits, WORD mode : 1,048,576 words by 16 bits).

The active levels of OE (Output Enable Input) can be selected with mask-option.

The  $\mu$ PD23C16300 is packed in 48-pin PLASTIC TSOP(I) and 48-pin TAPE FBGA.

# Features

- Pin compatible with NOR Flash Memory
- Word organization
  - 2,097,152 words by 8 bits (BYTE mode)
  - 1,048,576 words by 16 bits (WORD mode)
- Operating supply voltage : Vcc = 2.7 V to 3.6 V

Operating supply voltage	Access time	Power supply current (Active mode)	Standby current (CMOS level input)
Vcc	ns (MAX.)	mA (MAX.)	μΑ (MAX.)
$3.0~V\pm0.3~V$	90	30	30
$3.3~V\pm0.3~V$	85		

#### **Ordering Information**

Part Number	Package	
μPD23C16300GZ-xxx-MJH	48-pin PLASTIC TSOP(I) (12 x 20) (Normal bent)	
μPD23C16300F9-xxx-BC3	48-pin TAPE FBGA (8 x 6)	

(xxx : ROM code suffix No.)

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The mark 🖈 shows major revised points.

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# **Pin Configurations**

/xxx indicates active low signal.

# 48-pin PLASTIC TSOP(I) (12 x 20) (Normal bent)

#### [ µPD23C16300GZ-xxx-MJH ]

#### Marking Side

		-	
A15 🔿 🗕 🗕	1 48	0	A16
A14 O	2 47	0	WORD, /BYTE
A13 ()	3 46	<u> </u>	GND
A12 O	4 45	0	O15, A–1
A11 O	5 44	<b></b> 0	07
A10 O	6 43	<b></b> 0	O14
A9 O	7 42	<b></b> 0	O6
A8 O	8 41	<b></b> 0	O13
A19 O	9 40	<b></b> 0	O5
NC ()	10 39	<b></b> 0	012
NC ()	11 38	0	O4
NC ()	12 37	<u> </u>	Vcc
NC O	13 36	<b></b> 0	O11
NC O	14 35	<b></b> 0	O3
NC O	15 34	0	O10
A18 O	16 33	<b></b> 0	O2
A17 O	17 32	<b></b> 0	O9
A7 O	18 31	<b></b> 0	01
A6 O	19 30	<b></b> 0	O8
A5 O	20 29	<b></b> 0	00
A4 O	21 28		/OE or OE or DC
A3 O	22 27	$\vdash \circ$	GND
A2 O	23 26		/CE
A1 O──►	24 25	<b></b> 0	A0
		1	

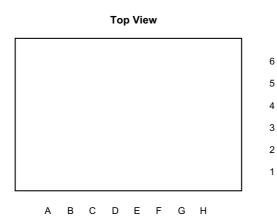
A0 to A19	:	Address inputs
O0 to O7, O8 to O14	<b>i</b> :	Data outputs
O15, A–1	:	Data output 15 (WORD mode),
		LSB Address input (BYTE mode)
WORD, /BYTE	:	Mode select
/CE	:	Chip Enable
/OE or OE	:	Output Enable
Vcc	:	Supply voltage
GND	:	Ground
NC Note	:	No Connection
DC	:	Don't Care

Note Some signals can be applied because this pin is not connected to the inside of the chip.

Remark Refer to Package Drawings for the 1-pin index mark.

# 48-pin TAPE FBGA (8 x 6)

# [ µPD23C16300F9-xxx-BC3 ]



	А	В	С	D	Е	F	G	Н
6	A13	A12	A14	A15	A16	WORD,	O15,	GND
						/BYTE	A–1	
5	A9	A8	A10	A11	07	O14	O13	O6
4	NC	NC	NC	A19	O5	O12	Vcc	04
3	NC	NC	A18	NC	O2	O10	011	O3
2	A7	A17	A6	A5	00	O8	O9	01
1	A3	A4	A2	A1	A0	/CE	/OE or	GND
							OE	

$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$
$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$
0	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$
$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$
$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$
$\bigcirc$	$\bigcirc$	$\bigcirc$	$\bigcirc$	0	$\bigcirc$	$\bigcirc$	$\bigcirc$
н	G	F	Е	D	С	В	А
	0 0 0 0						0 0 0 0 0 0 0 0

**Bottom View** 

	Н	G	F	Е	D	С	В	А
6	GND	O15,	WORD,	A16	A15	A14	A12	A13
		A–1	/BYTE					
5	O6	O13	O14	07	A11	A10	A8	A9
4	04	Vcc	O12	O5	A19	NC	NC	NC
3	O3	O11	O10	O2	NC	A18	NC	NC
2	01	O9	O8	O0	A5	A6	A17	A7
1	GND	/OE or	/CE	A0	A1	A2	A4	A3
		OE						

A0 to A19	:	Address inputs
O0 to O7, O8 to O14		Data outputs
O15, A–1	:	Data output 15 (WORD mode),
		LSB Address input (BYTE mode)
WORD, /BYTE	:	Mode select
/CE	:	Chip Enable
/OE or OE	:	Output Enable
Vcc	:	Supply voltage
GND	:	Ground
NC Note	:	No Connection
DC	:	Don't Care

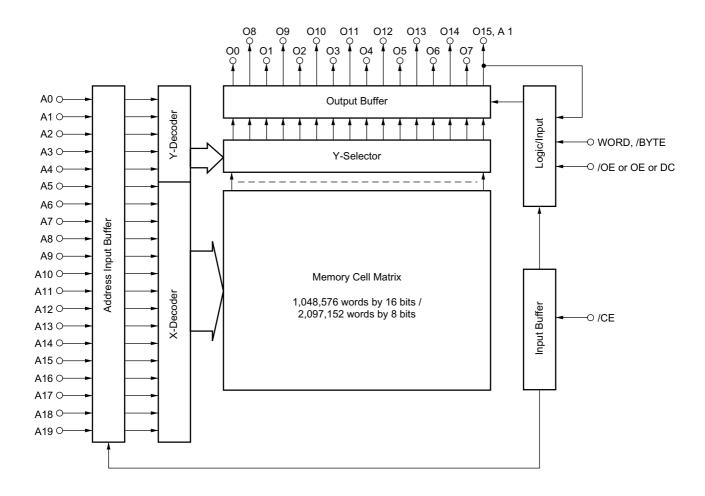
Note Some signals can be applied because this pin is not connected to the inside of the chip.

Remark Refer to Package Drawings for the index mark.

# Input / Output Pin Functions

Pin name	Input / Output	Function	
WORD, /BYTE	Input	The pin for switching WORD mode and BYTE mode.	
		High level : WORD mode (1M-word by 16-bit)	
		Low level : BYTE mode (2M-word by 8-bit)	
A0 to A19	Input	Address input pins.	
(Address inputs)		A0 to A19 are used differently in the WORD mode and the BYTE mode.	
		WORD mode (1M-word by 16-bit)	
		A0 to A19 are used as 20 bits address signals.	
		BYTE mode (2M-word by 8-bit)	
		A0 to A19 are used as the upper 20 bits of total 21 bits of address signal.	
		(The least significant bit (A–1) is combined to O15.)	
O0 to O7, O8 to O14	Output	Data output pins.	
(Data outputs)		O0 to O7, O8 to O14 are used differently in the WORD mode and the BYTE mode.	
		WORD mode (1M-word by 16-bit)	
		The lower 15 bits of 16 bits data outputs to O0 to O14.	
		(The most significant bit (O15) combined to A-1.)	
		BYTE mode (2M-word by 8-bit)	
		8 bits data outputs to O0 to O7 and also O8 to O14 are high impedance.	
O15, A–1	Output, Input	O15, A–1 are used differently in the WORD mode and the BYTE mode.	
(Data output 15,		WORD mode (1M-word by 16-bit)	
LSB Address input)		The most significant output data bus (O15).	
		BYTE mode (2M-word by 8-bit)	
		The least significant address bus (A–1).	
/CE	Input	Chip activating signal.	
(Chip Enable)		When the OE is active, output states are following.	
		High level : High-Z	
		Low level : Data out	
/OE or OE or DC	Input	Output enable signal. The active level of OE is mask option. The active level of OE	
(Output Enable, Don't care)		can be selected from high active, low active and Don't care at order.	
Vcc	-	Supply voltage	
GND	_	Ground	
NC	-	Not internally connected. (The signal can be connected.)	

# **Block Diagram**



# **Mask Option**

The active levels of output enable pin (/OE or OE or DC) are mask programmable and optional, and can be selected from among " 0 " " 1 " " x " shown in the table below.

Option	/OE or OE or DC	OE active level
0	/OE	L
1	OE	Н
x	DC	Don't care

Operation modes for each option are shown in the tables below.

Operation mode (Option : 0)

/CE	/OE	Mode	Output state
L	L	Active	Data out
	Н		High-Z
Н	H or L	Standby	High-Z

Operation mode (Option : 1)

/CE	OE	Mode	Output state
L	L	Active	High-Z
	Н		Data out
Н	H or L	Standby	High-Z

Operation mode (Option : x)

/CE	DC	C Mode Output state		
L	H or L	Active	Data out	
Н	H or L	Standby	High-Z	

Remark L: Low level input

H : High level input

# **Electrical Specifications**

#### **Absolute Maximum Ratings**

Parameter	Symbol	Condition	Rating	Unit
Supply voltage	Vcc		–0.3 to +4.6	V
Input voltage	Vı		–0.3 to Vcc+0.3	V
Output voltage	Vo		–0.3 to Vcc+0.3	V
Operating ambient temperature	TA		-10 to +70	°C
Storage temperature	Tstg		–65 to +150	°C

Caution Exposing the device to stress above those listed in Absolute Maximum Ratings could cause permanent damage. The device is not meant to be operated under conditions outside the limits described in the operational section of this specification. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability.

# Capacitance (TA = 25 °C)

Parameter	Symbol	Test condition	MIN.	TYP.	MAX.	Unit
Input capacitance	Сі	f = 1 MHz			10	pF
Output capacitance	Co				12	pF

# DC Characteristics (TA = -10 to +70 °C, Vcc = 2.7 to 3.6 V)

Parameter	Symbol	Test conditions	MIN.	TYP.	MAX.	Unit
High level input voltage	VIH		2.0		Vcc + 0.3	V
Low level input voltage	VIL	Vcc = 3.0 V ± 0.3 V	-0.3		+0.5	V
		Vcc = 3.3 V ± 0.3 V	-0.3		+0.8	
High level output voltage	Vон	Іон = –100 μА	2.4			V
Low level output voltage	Vol	IoL = 2.1 mA			0.4	V
Input leakage current	lu	VI = 0 V to Vcc	-10		+10	μA
Output leakage current	Ilo	$V_0 = 0 V$ to $V_{CC}$ , Chip deselected	-10		+10	μA
Power supply current	Icc1	/CE = V <sub>IL</sub> (Active mode), I₀ = 0 mA			30	mA
Standby current	Іссз	/CE = Vcc – 0.2 V (Standby mode)			30	μA

#### AC Characteristics (TA = -10 to +70 °C, Vcc = 2.7 to 3.6 V)

	Parameter	Symbol	Test condition	Vcc =	= 3.0 V ± (	).3 V	Vcc =	= 3.3 V ± (	).3 V	Unit
				MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	
	Address access time	tacc				90			85	ns
*	Address skew time	<b>t</b> skew	Note			10			10	ns
	Chip enable access time	<b>t</b> CE				90			85	ns
	Output enable access time	toe				25			25	ns
	Output hold time	tон		0			0			ns
	Output disable time	<b>t</b> DF		0		25	0		25	ns
	WORD, /BYTE access time	twв				90			85	ns

**\*** Note tskew indicates the following three types of time depending on the condition.

1) When switching /CE from high level to low level, tskew is the time from the /CE low level input point until the next address is determined.

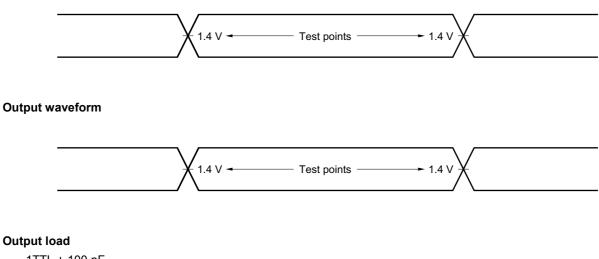
- 2) When switching /CE from low level to high level, tskew is the time from the address change start point to the /CE high level input point.
- 3) When /CE is fixed to low level, tskew is the time from the address change start point until the next address is determined.

Since specs are defined for tskew only when /CE is active, tskew is not subject to limitations when /CE is switched from high level to low level following address determination, or when the address is changed after /CE is switched from low level to high level.

**Remark** toF is the time from inactivation of Chip Enable input (/CE) or Output Enable input (/OE or OE) to high impedance state output.

# **AC Test Conditions**

Input waveform (Rise / Fall time  $\leq$  5 ns)



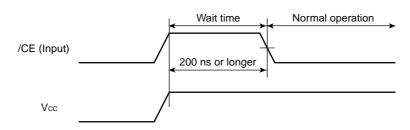
1TTL + 100 pF

#### ★ Cautions on power application

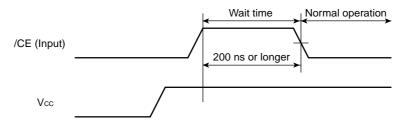
To ensure normal operation, always apply power using /CE following the procedure shown below.

- 1) Input a high level to /CE during and after power application.
- 2) Hold the high level input to /CE for 200 ns or longer (wait time).
- 3) Start normal operation after the wait time has elapsed.

#### Power Application Timing Chart 1 (When /CE is made high at power application)



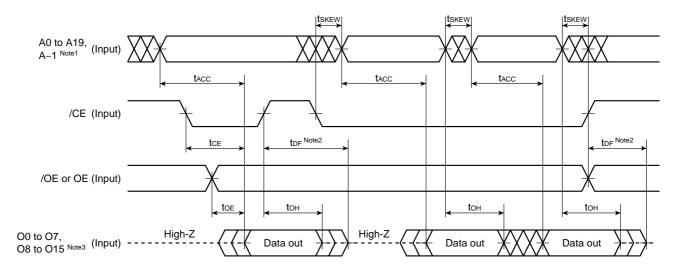
#### Power Application Timing Chart 2 (When /CE is made high after power application)



Caution Other signals can be either high or low during the wait time.

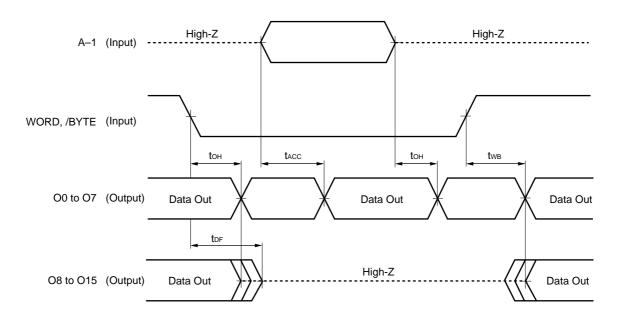
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# ★ Read Cycle Timing Chart



- Notes 1. During WORD mode, A-1 is O15.
  - 2. tDF is the time from inactivation of Chip Enable input (/CE) or Output Enable input (/OE or OE) to high impedance state output.
  - 3. During BYTE mode, O8 to O14 are high impedance and O15 is A-1.

#### WORD, /BYTE Switch Timing Chart

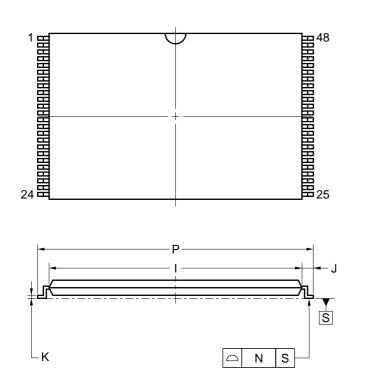


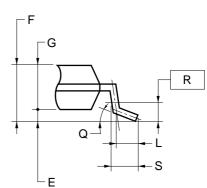
Remark Chip Enable (/CE) and Output Enable (/OE or OE) : Active.

Data Sheet M15705EJ2V0DS

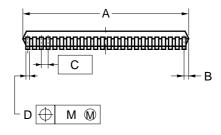
# Package Drawings

# 48-PIN PLASTIC TSOP (I) (12x20)





detail of lead end

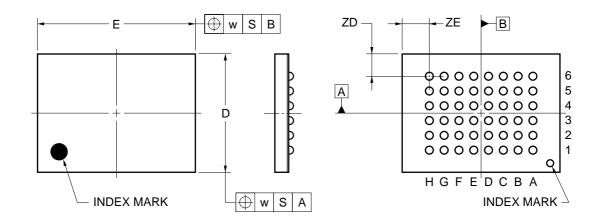


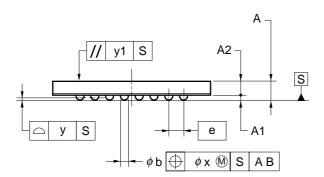
#### NOTES

- 1) Each lead centerline is located within 0.10 mm of its true position (T.P.) at maximum material condition.
- 2) "A" excludes mold flash. (Includes mold flash : 12.4 mm MAX.)

ITEM	MILLIMETERS
A	12.0±0.1
В	0.45 MAX.
С	0.5 (T.P.)
D	0.22±0.05
E	0.1±0.05
F	1.2 MAX.
G	1.0±0.05
I	18.4±0.1
J	0.8±0.2
К	0.145±0.05
L	0.5
М	0.10
N	0.10
Р	20.0±0.2
Q	$3^{\circ + 5^{\circ}}_{-3^{\circ}}$
R	0.25
S	0.60±0.15
	S48GZ-50-MJH-1

# \* 48-PIN TAPE FBGA(8x6)





ITEM	MILLIMETERS
D	6.0±0.1
E	8.0±0.1
w	0.2
е	0.80
А	0.97±0.10
A1	0.27±0.05
A2	0.70
b	0.45±0.05
x	0.08
у	0.1
y1	0.2
ZD	1.00
ZE	1.20
	P48F9-80-BC3

# **Recommended Soldering Conditions**

Please consult with our sales offices for soldering conditions of the  $\mu$ PD23C16300.

# Types of Surface Mount Device

 $\mu$ PD23C16300GZ-MJH : 48-pin PLASTIC TSOP(I) (12 x 20) (Normal bent)  $\mu$ PD23C16300F9-BC3 : 48-pin TAPE FBGA (8 x 6)

# **Revision History**

Edition/	Page		Type of	Location	Description
Date	This Previous		revision		(Previous edition $\rightarrow$ This edition)
	edition	edition			
2nd edition/	Throughout	Throughout	Modification		Preliminary Data Sheet $\rightarrow$ Data Sheet
Feb. 2003	003 p.8 p.8		Addition	AC Characteristics	Address skew time (tskew)
					Note
	р.9	Ι	Addition		Cautions on power application
	p.10 p.9		Modification		Read Cycle Timing Chart
	p.12	p.11	Modification	Package Drawings	Preliminary version $\rightarrow$ Standard version

#### - NOTES FOR CMOS DEVICES -

# **①** PRECAUTION AGAINST ESD FOR SEMICONDUCTORS

#### Note:

Strong electric field, when exposed to a MOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred. Environmental control must be adequate. When it is dry, humidifier should be used. It is recommended to avoid using insulators that easily build static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work bench and floor should be grounded. The operator should be grounded using wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with semiconductor devices on it.

# (2) HANDLING OF THE APPLIED WAVEFORM OF INPUT PINS AND THE UNUSED INPUT PINS FOR CMOS

Note:

Input levels of CMOS devices must be fixed. CMOS devices behave differently than Bipolar or NMOS devices. If the input of a CMOS device stays in an area that is between V<sub>IL</sub> (MAX.) and V<sub>IH</sub> (MIN.) due to the effects of noise or some other irregularity, malfunction may result. Therefore, not only the input waveform is fixed, but also the waveform changes, it is important to use the CMOS device under AC test conditions. For unused input pins in particular, CMOS devices should not be operated in a state where nothing is connected, so input levels of CMOS devices must be fixed to high or low by using pull-up or pull-down circuitry. Each unused pin should be connected to V<sub>DD</sub> or GND with a resistor, if it is considered to have a possibility of being an output pin. All handling related to the unused pins must be judged device by device and related specifications governing the devices.

#### **③** STATUS BEFORE INITIALIZATION OF MOS DEVICES

#### Note:

Power-on does not necessarily define initial status of MOS device. Production process of MOS does not define the initial operation status of the device. Immediately after the power source is turned ON, the devices with reset function have not yet been initialized. Hence, power-on does not guarantee out-pin levels, I/O settings or contents of registers. Device is not initialized until the reset signal is received. Reset operation must be executed immediately after power-on for devices having reset function.

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